## Application/Control No. Applicant(s)/Patent Under Reexamination 10/666,873 TSUKAMOTO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dah-Wei D. Yuan 1745 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 03-2004 US-2004/0053118 Tsukamoto et al. Α 429/094 US-В US-С US-D US-E US-F US-G US-Н US-US-J US-

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